

Diode - PN Junctions and Metal Semiconductor Contacts

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Sep.4 2019

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1 PN Junction

Definition 1 (PN Junction) An *intimate contact* (interface between two materials that allows free carriers to move across the boundary) between ***n-type*** (cathode) and ***p-type*** (anode) ***semiconductors***. The ***forward bias*** is defined when *p-type* is at higher voltage than *n-type*.

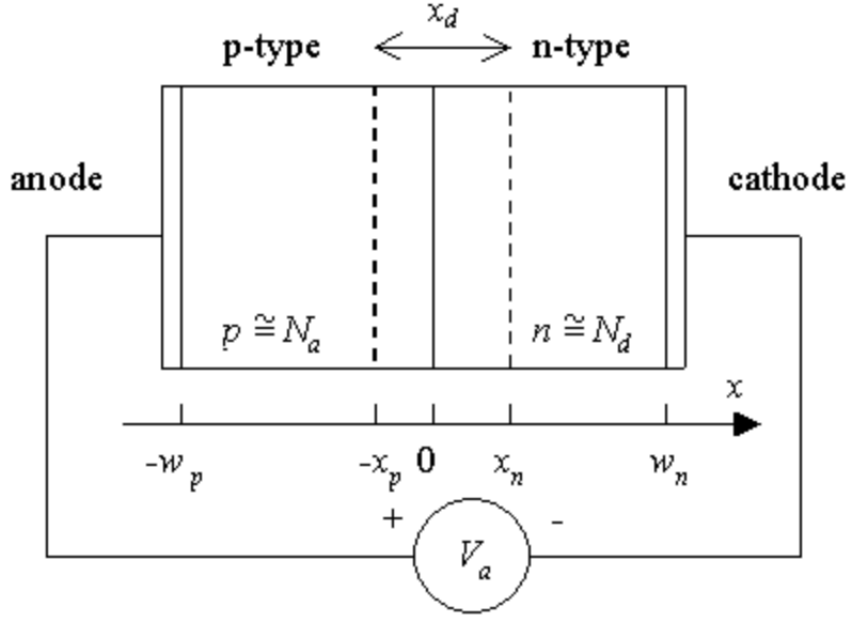


Figure 1: Crosssection of a PN junction. https://ecee.colorado.edu/~bart/book/book/chapter4/ch4_2.htm

Three steps to form a PN junction: (1) Two separate p- and n-type semiconductors of the same material. (2) Two semiconductors brought into contact immediately. (3) After enough time they reach thermal equilibrium.

When the device reaches equilibrium, the Fermi level is constant through the system. Far away from the PN junction, the electrical properties will be the same as isolated semiconductors.

Definition 2 (Energy barrier) *The energy difference between p-type side and n-type side in the band picture. It is represented by the built-in potential ϕ_i and equal to the difference in Fermi energy before the junction is formed.*

According to the definition of potential,

$$\begin{aligned}\phi_n &= \frac{E_F - E_i}{q} = kT \ln \frac{n}{n_i} = kT \ln \frac{N_D}{n_i} \\ \phi_p &= \frac{E_i - E_F}{q} = kT \ln \frac{n_i}{p} = -kT \ln \frac{N_A}{n_i} \\ \Rightarrow \phi_i &= \phi_n - \phi_p = kT \ln \frac{N_D N_A}{n_i^2} \text{ and } q\phi_i = (E_F)_n - (E_F)_p\end{aligned}$$

Definition 3 (Depletion Approximation) *The semiconductor can be divided into two regions: the depletion region (near pn-junction, no mobile carrier) and quasi-neutral region (far from pn junction, $n = N_D$ (n-type) or N_A (p-type)). At the boundary of depletion region and quasi-neutral region the carrier concentration changes **abruptly**.*

1.1 PN Junction with Various Doping Profiles

1.1.1 Step Junction

Step junction: Abrupt junction between uniformly doped p and n semiconductors. Applying the depletion approximation, the Poisson's equation within the depletion region ($p = n = 0$):

$$\frac{d^2 \phi}{dx^2} = -\frac{\rho(x)}{\epsilon_s} = -\frac{q}{\epsilon_s} (p - n + N_D - N_A) = -\frac{q}{\epsilon_s} (N_D - N_A)$$

In n-type region ($0 < x < x_n$):

$$\frac{d^2\phi}{dx^2} = -\frac{qN_D}{\epsilon_s} = -\frac{dE}{dx}$$

$$\text{Boundary condition : } E(x = x_n) = 0$$

$$\Rightarrow E(x) = -\frac{qN_D}{\epsilon_s}(x_n - x)$$

In p-type region ($-x_p < x < 0$):

$$\frac{d^2\phi}{dx^2} = \frac{qN_A}{\epsilon_s} = -\frac{dE}{dx}$$

$$\text{Boundary condition : } E(x = -x_p) = 0$$

$$\Rightarrow E(x) = -\frac{qN_A}{\epsilon_s}(x_p + x)$$

At $x=0$, the electric field should be continuous:

$$\frac{qN_D x_n}{\epsilon_s} = \frac{qN_A x_p}{\epsilon_s} \Rightarrow N_D x_n = N_A x_p$$

which is just the charge neutrality condition. It means that total negative charges generated should be equal to positive ones.

1.1.2 Linearly Graded PN Junction

1.2 C-V and I-V Characteristics

1.3 Junction Breakdown

1.4 Heterojunction

2 Metal-Semiconductor Contacts

2.1 Schottky Contact

2.2 Ohmic Contact

3 Optoelectronic Devices

3.1 Light Emitting Diode (LED)

3.2 Laser Diode

3.3 Photodiode

3.4 Solar Cell